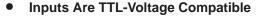
# 74ACT11478 METASTABLE-RESISTAND OCTAL D-TYPE DUAL-RANK FLIP-FLOP WITH 3-STATE OUTPUTS

SCAS131 - APRIL 1990 - REVISED APRIL 1993



- Specifically Designed for Data Synchronization Applications
- Improved Metastable Characteristics Provide Greater System Reliability
- 3-State Outputs Drive Bus Lines Directly
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V<sub>CC</sub> and GND Configurations to Minimize High-Speed Switching Noise
- EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) 1-µm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small Outline Packages and Standard Plastic 300-mil DIPs

#### **DW OR NT PACKAGE** (TOP VIEW) 24 OE 1Q L 2Q [[ 23 II 1D 3Q 🛮 3 22 2D 4Q [] 21 🛮 3D GND 5 20 **4**D GND [] 6 19 V<sub>CC</sub> 18 V<sub>CC</sub> GND ∏ 7 GND 8 17 🛮 5D 5Q **∏** 9 16**∏** 6D 15 7D 6Q **1** 10 7Q **∏** 11 14**∏** 8D 13 CLK 8Q ∏ 12

### description

The 74ACT11478 is an 8-bit dual-rank synchronizer circuit designed specifically for data synchronization applications where the normal setup and hold time specifications are frequently violated.

Synchronization of two digital signals operating at different frequencies is a common system problem. This problem is typically solved by synchronizing one of the signals to the local clock through a flip-flop. This solution, however, causes the setup and hold time specifications associated with the flip-flop to be violated. When the setup or hold time specification is violated, the output response is uncertain.

A flip-flop is metastable if its output hangs up in the region between  $V_{IL}$  and  $V_{IH}$ . The metastable condition lasts until the flip-flop recovers into one of its two stable states. With conventional flip-flops, this recovery time can be longer than the specified maximum propagation delay.

The problem of metastability is typically solved by adding an additional layer of synchronization. This type of dual ranking is employed in the 74ACT11478. The probability of the second stage entering the metastable state is exponentially reduced by this dual-rank architecture. The 74ACT11478 provides a one-chip solution for system designers in asynchronous applications.

The 74ACT11478 is characterized for operation from – 40°C to 85°C.

## FUNCTION TABLE (each flip-flop)

	INPUTS	OUTPUT	
OE	сьоск†	D	Q
Н	Х	Χ	Z
L	$\uparrow$	L	L
L	$\uparrow$	Н	Н
L	Н	X	QO

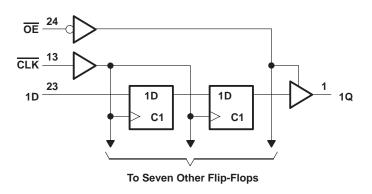
† Data presented at the D input requires two clock cycles to appear at the Q output.

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### logic symbol†

#### OE 24 ΕN <u>13</u> CLK > C1 23 1D 1D 1Q 1D 22 2Q 3 21 3Q 3D 20 4Q 17 9 16 10 6Q 15 11 7D 7Q 14 12 8Q 8D

### logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub>	– 0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	– 0.5 V to V <sub>CC</sub> + 0.5 V
Output voltage range, V <sub>O</sub> (see Note 1)	– 0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )	± 20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )	± 50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	± 50 mA
Continuous current through V <sub>CC</sub> or GND	± 200 mA
Storage temperature range	– 65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
IOH	High-level output current		- 24	mA
loL	Low-level output current		24	mA
$\Delta_{t/\Delta V}$	Input transition rise or fall rate	0	10	ns /V
TA	Operating free-air temperature	- 40	85	°C

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	$V_{CC} = \frac{T_A = 25^{\circ}C}{MIN TYP MAX}$	T <sub>A</sub> = 25°C				MAN	LINUT
PARAMETER	TEST CONDITIONS		IVIIN	0.1 0.1 0.44 0.44 1.65 ±5 ±1 80	UNIT			
		4.5 V	4.4			4.4		
	ΙΟΗ = – 50 μΑ	5.5 V	5.4			5.4		
Voн	1	4.5 V	3.94			3.8		V
	I <sub>OH</sub> = - 24 mA	5.5 V	4.94			4.8		
	I <sub>OH</sub> = - 75 mA <sup>†</sup>	5.5 V				3.85		
	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1	
VOL		5.5 V			0.1		0.1	
		4.5 V			0.36		0.44	V
	I <sub>OL</sub> = 24 mA	5.5 V			0.36		0.44	
	I <sub>OL</sub> = 75 mA <sup>†</sup>	5.5 V					4.4 5.4 3.8 4.8 3.85 0.1 0.1 0.44 0.44 1.65 ±5 ±1 80	
loz	$V_O = V_{CC}$ or GND	5.5 V			± 0.5		± 5	μΑ
lį	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	μΑ
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Δl <sub>CC</sub> ‡	One input at 3.4 V, Other inputs at GND or V <sub>CC</sub>	5.5 V			0.9		1	mA
C <sub>i</sub>	$V_I = V_{CC}$ or GND	5 V		4.5				pF
Co	$V_O = V_{CC}$ or GND	5 V		12				pF

<sup>&</sup>lt;sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

## timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				T <sub>A</sub> = 2	25°C			
				MIN	MAX	MIN	MAX	UNIT
f <sub>clock</sub>	Clock frequency			0	75	0	75	MHz
_	Pulse duration	CLK high		4		4		
t <sub>W</sub>		CLK low		5		5		ns
t <sub>su</sub>	Setup time, data before CLK↑		·	2.7		2.7		ns
t <sub>h</sub>	Hold time, data after CLK↑		·	1.5		1.5		ns

## switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

DADAMETER	FROM	ТО	T <sub>A</sub> = 25°C					
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	UNIT
f <sub>max</sub>			7.5			75		MHz
t <sub>PLH</sub>	CLK	Q	4.3	7.4	10.1	4.3	11.6	ns
<sup>t</sup> PHL			5.6	9.4	12.6	5.6	14.2	
<sup>t</sup> PZH	ŌĒ	0	3.7	7.5	11.1	3.7	12.6	
tPZL		Q	4.7	9.2	13.7	4.7	15.8	ns
<sup>t</sup> PHZ	ŌĒ	0	4.4	7.2	9.2	4.4	9.8	
t <sub>PLZ</sub>	OE .	Q	4.7	6.6	8.7	4.7	9.3	ns

<sup>‡</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

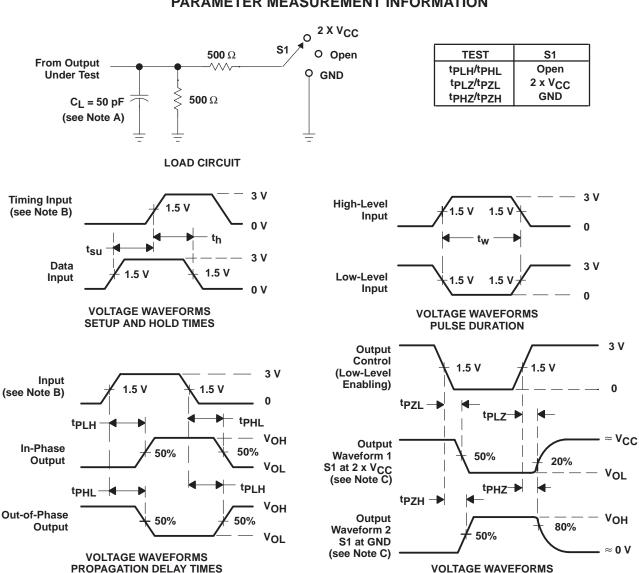
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### operating characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

PARAMETER			TEST CON	TYP	UNIT	
C Payer dissination consists and notified	Decree disciplination of the second of the s	Outputs enabled	0 50 5	0 50 5 ( 4 1 1 1 5	76	
Cpd		Outputs disabled	$C_L = 50 pF$ ,	f = 1 MHz	64	pF

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f = 3$  ns,  $t_f = 3$  ns.

**ENABLE AND DISABLE TIMES** 

- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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